

November 1988 Revised November 1999

74AC20 Dual 4-Input NAND Gate

General Description

The AC20 contains four 4-input NAND gates.

Features

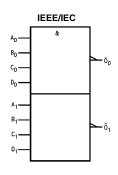
- I_{CC} reduced by 50%
- Outputs source/sink 24 mA

Ordering Code:

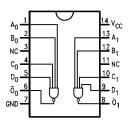
Order Number	Package Number	Package Description				
74AC20SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body				
74AC20SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide				
74AC20MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide				
74AC20PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide				

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description			
A_n , B_n , C_n , D_n	Inputs			
\overline{O}_n	Outputs			

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Absolute Maximum Ratings(Note 1)

-0.5V to +7.0V

-0.5 V to $V_{CC} + 0.5 V$

DC Input Diode Current (I_{IK})

Supply Voltage (V_{CC})

-20 mA

 $V_I = -0.5V$ $V_I = V_{CC} + 0.5V$ +20 mA

DC Input Voltage (V_I) -0.5 V to $\text{V}_{\text{CC}} + 0.5 \text{V}$

DC Output Diode Current (I_{OK})

 $V_O = -0.5V$ -20 mA $V_O = V_{CC} + 0.5V$ +20 mA

DC Output Voltage (V_O)

DC Output Source or Sink Current (IO) \pm 50 mA

DC V_{CC} or Ground Current

 \pm 50 mA per Output Pin (I_{CC} or I_{GND}) -65°C to +150°C

Storage Temperature (T_{STG}) Junction Temperature (T_J)

PDIP 140°C

Recommended Operating Conditions

Supply Voltage (V_{CC}) 2.0V to 6.0V Input Voltage (V_I) 0V to V_{CC} 0V to $V_{\mbox{\footnotesize CC}}$ Output Voltage (V_O) -40°C to +85°C Operating Temperature (T_A)

Minimum Input Edge Rate (ΔV/Δt) 125 mV/ns

 $\rm V_{IN}$ from 30% to 70% of $\rm V_{CC}$ V_{CC} @ 3.3V, 4.5V, 5.5V

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACTIM circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter	V _{CC}	T _A = +25°C		$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	Units	Conditions
Symbol		(V)	Тур	Guaranteed Limits		Offics	Conditions
V _{IH}	Minimum HIGH Level	3.0	1.5	2.1	2.1		V _{OUT} = 0.1V
	Input Voltage	4.5	2.25	3.15	3.15	V	or V _{CC} – 0.1V
		5.5	2.75	3.85	3.85		
V _{IL}	Maximum LOW Level	3.0	1.5	0.9	0.9		V _{OUT} = 0.1V
	Input Voltage	4.5	2.25	1.35	1.35	V	or V _{CC} - 0.1V
		5.5	2.75	1.65	1.65		
V _{OH}	Minimum HIGH Level	3.0	2.99	2.9	2.9		
	Output Voltage	4.5	4.49	4.4	4.4	V	$I_{OUT} = -50 \mu A$
		5.5	5.49	5.4	5.4		
							$V_{IN} = V_{IL}$ or V_{IH}
		3.0		2.56	2.46		$I_{OH} = -12 \text{ mA}$
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA (Note 2)}$
V _{OL}	Maximum LOW Level	3.0	0.002	0.1	0.1		
	Output Voltage	4.5	0.001	0.1	0.1	V	$I_{OUT} = 50 \mu A$
		5.5	0.001	0.1	0.1		
							$V_{IN} = V_{IL}$ or V_{IH}
		3.0		0.36	0.44		I _{OL} = 12 mA
		4.5		0.36	0.44	V	I _{OL} = 24 mA
		5.5		0.36	0.44		I _{OL} = 24 mA (Note 2)
I _{IN}	Maximum Input	5.5		± 0.1	± 1.0	μА	V _I = V _{CC} , GND
(Note 4)	Leakage Current	5.5		± 0.1	± 1.0	μА	V _I = V _{CC} , GND
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max
I _{OHD}	Output Current (Note 3)	5.5			-75	mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent	5.5		2.0	20.0	μΑ	$V_{IN} = V_{CC}$
(Note 4)	Supply Current						or GND

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC}.

AC Electrical Characteristics

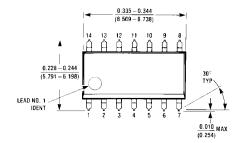
Symbol	Parameter	V _{CC} (V)	$T_A = +25$ °C $C_L = 50 \text{ pF}$			$T_A = -40$ °C to +85°C $C_L = 50$ pF		Units
		(Note 5)	Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	3.3	2.0	6.0	8.5	1.5	10.0	20
		5.0	1.5	5.0	7.0	1.0	8.0	ns
t _{PHL}	Propagation Delay	3.3	1.5	5.0	7.0	1.0	9.0	ns
		5.0	1.5	4.0	6.0	1.0	7.0	115

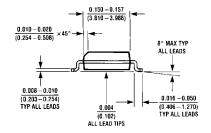
Note 5: Voltage Range 3.3 is $3.3V \pm 0.3V$ Voltage Range 5.0 is $5.0V \pm 0.5V$

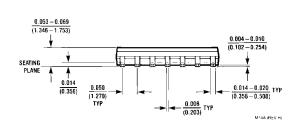
Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
CPD	Power Dissipation Capacitance	40.0	pF	$V_{CC} = 5.0V$

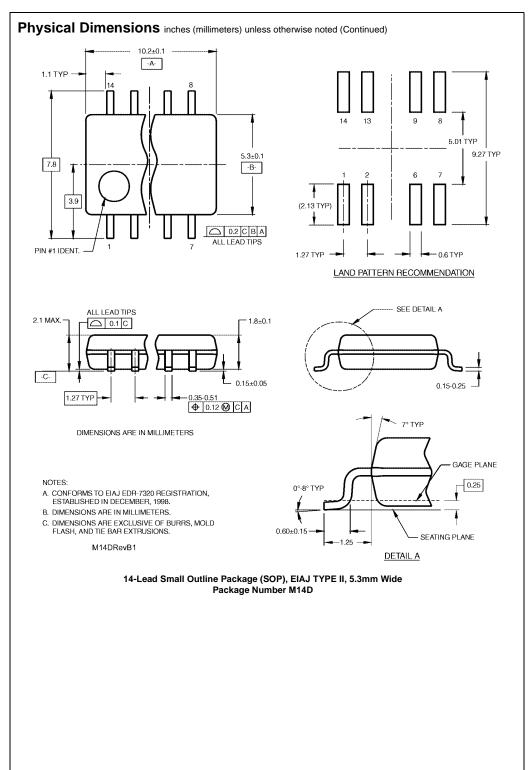
$\textbf{Physical Dimensions} \ \ \textbf{inches} \ \ \textbf{(millimeters)} \ \ \textbf{unless otherwise noted}$





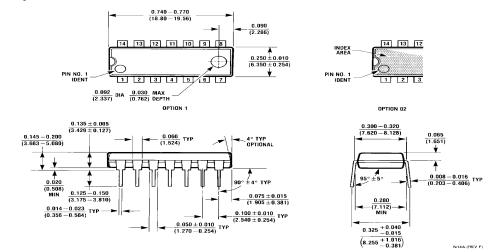


14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body Package Number M14A



$\begin{picture}(200,0)\put(0,0){\line(1,0){100}} \put(0,0){\line(1,0){100}} \put(0,0){\line(1,0){100$ 5.0±0.1 -A-0.43 TYP-4.16 6.4 -B-3.2 0.2 CBA ALL LEAD TIPS 0.65 LAND PATTERN RECOMMENDATION PIN #1 IDENT. SEE DETAIL A ALL LEAD TIPS - 0.90 ^{+0.15} 0.10±0.05 0.19 - 0.30 ⊕ 0.13 M A BS CS 0.65 -12.00° TOP & BOTTOM R0.09 MIN-GAGE PLANE NOTES: A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATE 7/93. B. DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS. 0.25 0.6 ±0.1 SEATING PLANE D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982. R0.09 MIN MTC14RevC3 DETAIL A 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

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